GENESIS ELECTRO-MECHANICAL LTD.

PRODUCT SPECIFICATION
GENESIS PN: 230-10089-01



SPECIFICATION FOR APPROVAL

CUSTOMER:			
CUSTOMER PA	RT NO:		
PART NO:	230-10089-01	REVISION: PSA	
DESCRIPTION:	Slim SAS 8i 85ohr	n Vertical SMT Receptacle	

	MANUFACTURE SIGNATURE	CUSTOMER SIGNATURE
APPROVED BY:	Ethan	
DATE:	2021.3.19	

GENESIS ELECTRO-MECHANICAL LTD.

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GENESIS ELECTRO-MECHANICAL LTD.

PRODUCT SPECIFICATION GENESIS PN: 230-10054-01

Revision history

版本	日期	摘 要	核准	審查	制修訂
PSA	2021.3.19	INITIAL	Hill	Hill	Ethan

Product Description: SlimSAS x4(x8) R/A 0.6mm Pitch Receptacle

1. SCOPE

This specification covers performance, methods and quality requirement for SlimSAS Receptacle connector.

2. APPLICABLE DOCUMENTS

The following documents form a part of this specification to the extent specified herein. Unless otherwise specified, latest edition of the specification applies. In the event of conflict between requirements of this specification and product drawing, product drawing shall take precedence.

- 2.1. Commercial standards, specifications and report
 - 2.1.1. EIA-364
 - 2.1.2. EIA-364-1000.01

3. REQUIREMENTS

3.1. Design and Construction

Product shall be of design, construction and physical dimensions specified on applicable product drawing.

3.2. Materials and Finish

3.2.1. See GENESIS Drawing

3.3. Ratings

- 3.3.1. Voltage: 30 VAC / contact
- 3.3.2. Current: 0.5 A/contact3.3.3. Operting Temperature: -40°C to $+85^{\circ}\text{C}$
- 3.3.4. Non-operating Temperature : -55° C TO $+85^{\circ}$ C
- 3.3.5. Storage Temperature : -20° C to $+85^{\circ}$ C

3.4. Performance and Test Description

Product is designed to meet electrical, mechanical and environmental performance requirements specified in Paragraph 3.5. All tests are performed at ambient environmental conditions per EIA-364 unless otherwise specified.

3.5. Test Requirements and Procedures Summary

Test Description	Requirement	Procedure					
Visual Inspection	The inspection results should be compliant with the individual specification.	Before the qualification test, all these components shall be examined the Features, Construction as per applicable specification and documents. (EIA-364-18)					
	ELECTRICA	AL					
Low Level Contact Resistance	20mΩ maximum for signal contacts (initial)	Measured at 20 mVolts(Max) open circuit at 100mA. (EIA 364-23)					
Insulation Resistance	1000 MΩ minimum between adjacent contacts	Test voltage 100±10V DC/2min between adjacent contacts of mated and unmated connector assemblies. (EIA 364-21)					
Dielectric Withstanding Voltage	No defect or breakdown between adjacent contacts No leakage current in excess of 1mA	Apply a voltage of 300 VDC for 1 minute (EIA 364-20)					
MECHANICAL							
Mating Force (With Latch Feature disable)	x4 version: 21N maximum x8 version: 31N maximum	The specimens are mounted to mounting fixtures by the normal mounting means. The insertion and withdrawal speed: 25 mm/minute(EIA-364-13)					
Un-mating Force (With Latch Feature disable)	x4 version:18N maximum x8 version: 24N maximum.	The specimens are mounted to mounting fixtures by the normal mounting means. The insertion and withdrawal speed: 25 mm/minute(EIA-364-13)					
Latch Plug Retention Force	50 N minimum.	Mate connector at a rate of 25 mm per min.					

Reseating See Note (a).		Manually unplug/plug the connector.					
Reseating	See Note (a).	Perform 3 such cycles.					
		Mate and unmated connector assemblies					
Durability	See Note (a).	for 50 cycles at maximum rate of					
(preconditioning)	230 2 300 (39)	500 cycles per hour.					
		(EIA-364-09)					
		Mate and unmated connector assemblies					
Durability	See Note (a).	for 250 cycles at maximum rate of					
		500 cycles per hour automatically.					
		(EIA-364-09) Both mating halves rigidly fixed to not					
	No discontinuities 1 µs or longer	contribute to relative motion of one					
	duration.	contribute to relative motion of one contact against another					
Vibration	$10 \text{ m}\Omega$ max. change from initial	Duration: 1 hour per axis / 3 axis					
	contact resistance	(EIA-364-28, Test Condition VII, Test					
	See Note (a).	Letter D)					
		Subject mated connectors to 30 G's					
	10 m 0 may shance from initial	half sine shook! pulses of 11ms duration					
	10 m Ω max. change from initial (baseline) contact resistance	Three shocks in each direction applied					
Mechanical Shock	See Note (a).	along three mutually perpendicular planes,					
	see Note (a).	18 total shocks.					
		(EIA-364-27, Condition H)					
Tommometumo Dice	+30°C max.	Measure the temperature rise at the rated					
Temperature Rise		current after 96 hours.(45 minutes ON and					
(via current cycling)	(Current rating: 0.5A)	15 minutes OFF). Fixture as required.					
	ENVIRONMEN	ITAL					
		Subject mated connectors to 10 cycles					
		between -55°~ 85°C, 30 minute dwell at					
Thermal Shock	See Note (a).	each temperature extreme.					
		(EIA-364-32, Condition I)					
		Subject mated connectors to cycle the					
		connector					
		Humidity: 90% - 95%					
		Temperature Range: 25°to 65°C					
		Duration: 60 cycles. (480 hours)					
		Cycle Definition: Each cycle should last					
Cyclic Temperature & Humidity	See Note (a).	8 hours. The cycle is a 2 hour dwell at					
	See Tiote (a).	the low temperature, a 2 hour ramp from					
		the low temperature to the high					
		temperature, a 2 hour dwell at the high					
		temperature, and a 2 hour ramp from the					
		high temperature to the low temperature.					
		(EIA-364-31)					

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Salt Spray		Salt solution concentration: 5±1%					
		The mated connector shall be subjected to					
	Class shell be satisfied	a fine mist of salt solution at temperature					
		of 35°±2°C for 48 hours continuously					
		(EIA-364-26)					
T		EIA-364-17, Method A(without electrical					
Temperature Life	See Note (a).	load). Mated connector. Expose 300 hours					
(preconditioning)	,	at 105° ± 2° C.					
		EIA-364-17, Method A (without electrical					
Temperature Life	See Note (a).	load). Mated connector. Expose 300 hours at					
Tomporadare Ente	See 1 (see (a).	105°±2°C.					
		Subject the test area of contacts into flux					
	Solder able area shall have	for 5~10 seconds and then into solder bath,					
Solderability	minimum of 95% solder	controlled at $245^{\circ}\pm5^{\circ}$ C, for 5 ± 0.5 seconds.					
	coverage.	, and the second					
		(EIA-364-52)					
D		Pre-Heat: 150°~180°C, 60~120 sec.					
Resistance to Reflow	See Note (a).	Heat Peak : 260° C, 10 sec. MAX.					
Soldering Heat		See Figure 1, Cycles: 2 times					
		(EIA-364-56)					
Mixed Flowing Gas		Duration: 10 days.					
	See Note (a).	Connectors should be mated during this					
		portion of the test.					
		(EIA-364-65,Class IIA)					
		The test specimens shall be mated during					
		the test.					
		Temperature Range: 15°C +/- 3°C to 85					
		°C +/- 3°C					
		Thermal Ramp: minimum of 1 °C per					
Thermal Disturbance	See Note (a).	minute. Dwell times should insure that the					
		contacts reach the extremes, no less than 5					
		minutes.					
		Number of cycles: 10.					
		Humidity does not need to be controlled					
		during this portion of the test.					
Б	G M ()	The test specimens shall be unmated during					
Dust	See Note (a).	the test.Benign Dust(EIA-364-91)					
		The test specimens shall be mated during					
		the test.					
		Temperature Range: 15°C±3°C to 85°C±3°C					
	See Note (a).	Thermal Ramp:minimum 1° per minute.					
Thermal Cycling		Dwell times should insure that the contact					
		reach the extremes, no less than 5 minutes.					
		Number of cycles: 500.					
		Humidity does not need to be controlled					
		during this portion of the test.					
(a) Shall most vigual	requirements show no physical	damage and shall meet requirements of					
(a) Shall meet visual	requirements, snow no physical	damage and shan meet requirements of					

additional tests as specified in Test Sequence in Table 1

3.6. Product Qualification and Test Sequence													
Test or Examination		Test Group											
		2	3	4	5	6 Test	7 Sequ	8	9	10	11	12	13
Visual Inspection	1,10	1,8	1,12	1,10	1,7	1,3	1,7	1,7	1,3	1,7	1,3	1,3	1,10
Low Level Contact Resistance	2,5,7	2,5,7	257	2,5,7	,,	7-		2,4,6	,-	, ,	7-	,-	2,5,7
Insulation Resistance	,,,		,,,,11	,,,						2,6			,,,
Dielectric Withstanding Voltage										3,5			
Mating Force					2,5								
Un-mating Force					3,6								
Durability (preconditioning)	3	3	3	3			3	3					3
Durability					4								
Temperature Life (preconditioning)		4	4										4
Temperature Life										4			
Thermal Shock	4												
Cyclic Temp. & Humidity	6												
Reseating	8		10	8			5						8
Mechanical Shock								5					
Vibration		6											
Solderability									2				
Resistance to Reflow Soldering Heat						2							
Salt spray							4						
Mixed Flowing Gas			6										
Thermal Disturbance			8	6									
Dust				4									
Temperature Rise											2		
Latch Plug Retention Force												2	
Thermal Cycling													6
Sample Size	5	5	5	5	5	5	5	5	5	5	5	5	5

Table 1

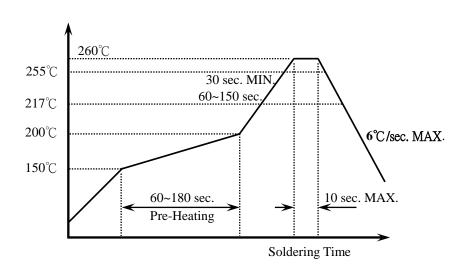


Figure 1. Recommended Reflow Temperature Profile